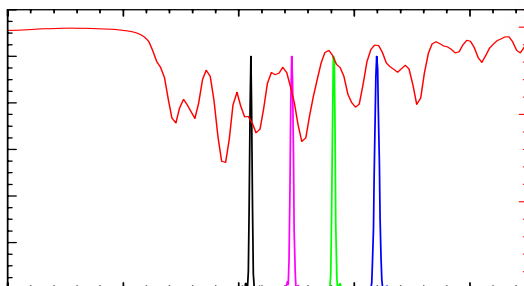
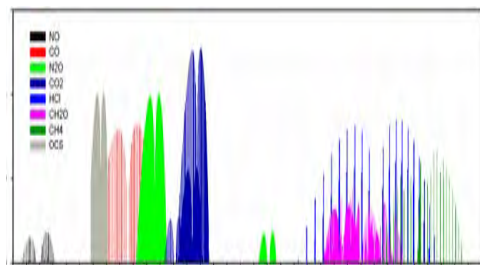
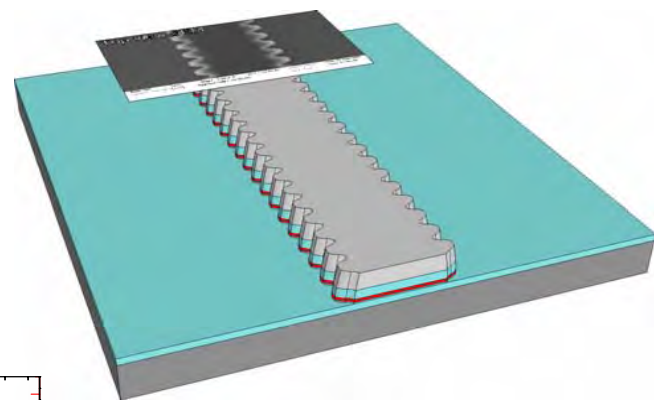
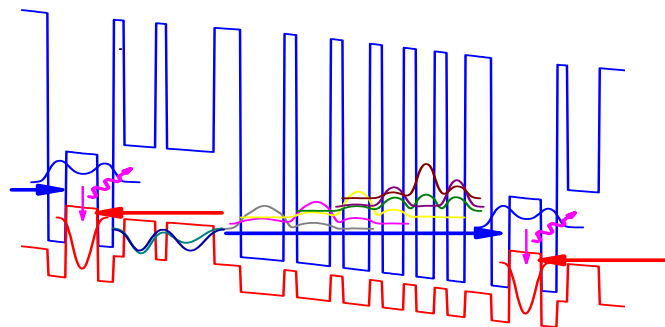


INTERBAND CASCADE LASERS FOR SPECTROSCOPY WITH VERY LOW INPUT POWER



***Laser Applications to Chemical, Security, and Environmental Analysis
(San Diego CA, 30 January 2012)***

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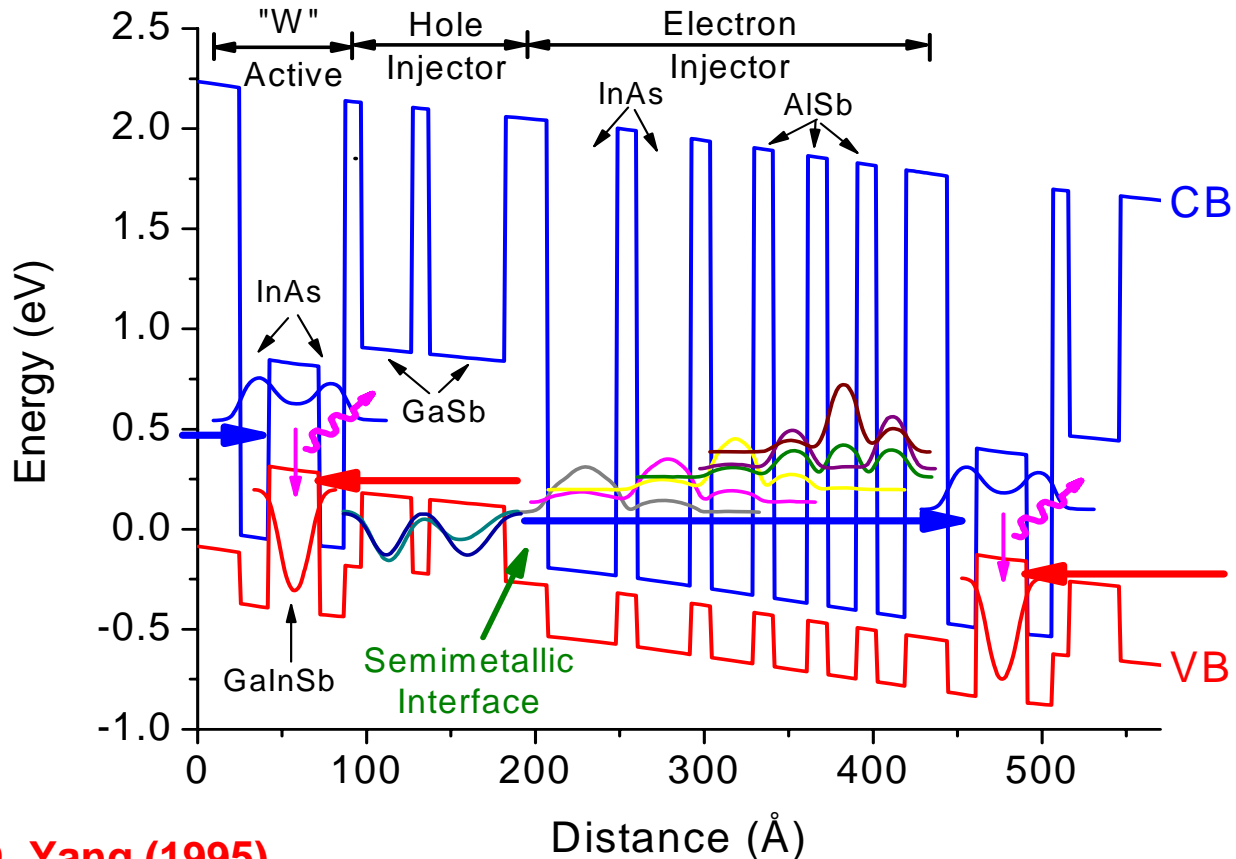
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THE INTERBAND CASCADE LASER (ICL)

Hybrid of conventional diode (Interband active transitions) & QCL (Cascaded multiple stages)



1st Proposed: R. Q. Yang (1995)

Design Improvements: Meyer & Vurgaftman (1996-1997)

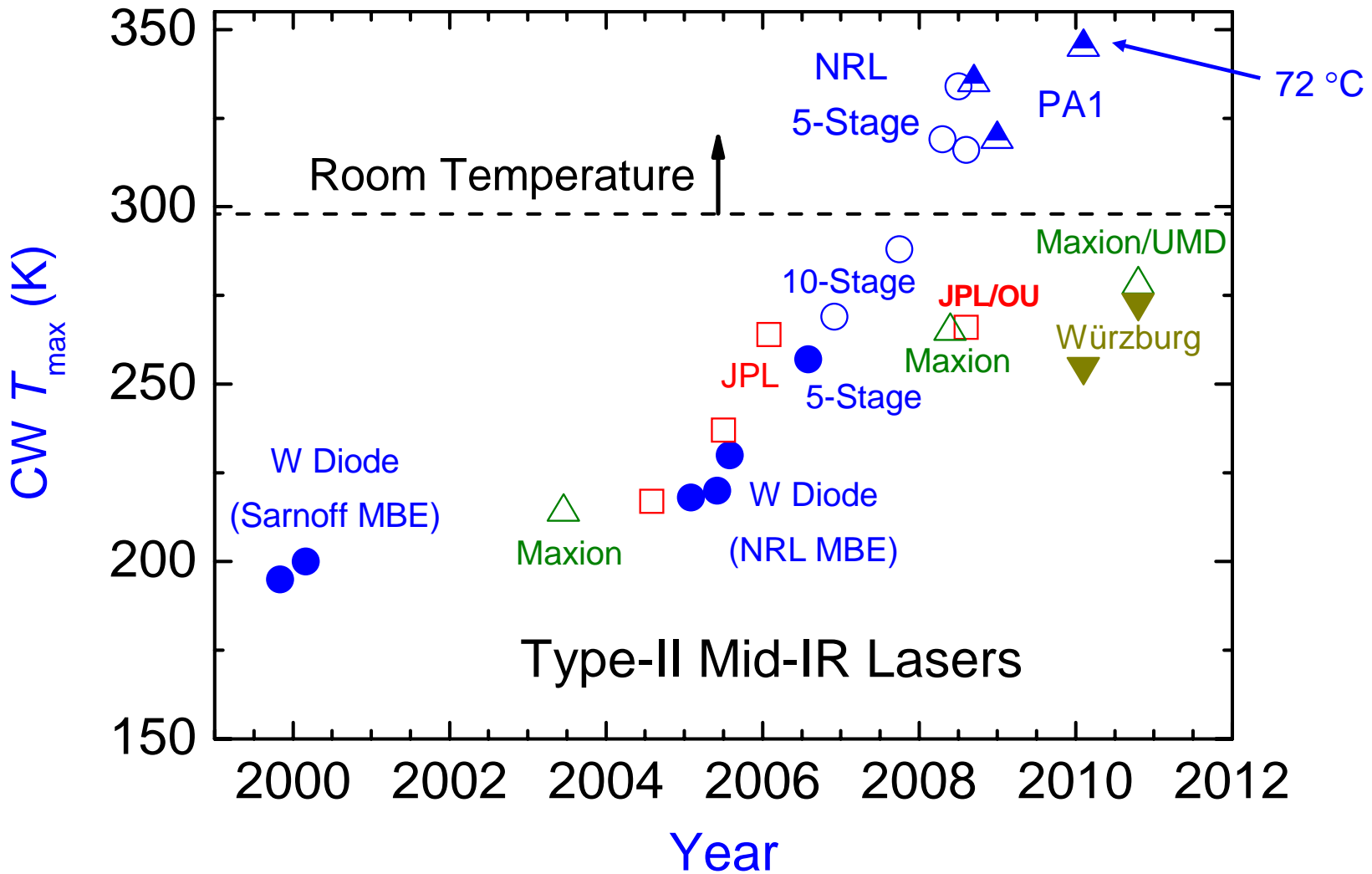
1st Experimental Demo: U. Houston & Sandia (1997)

Further Developed: ARL, Maxion, JPL, U. Oklahoma, U. Würzburg

1st NRL ICL: August 2005



BEYOND THE ROOM-TEMPERATURE BARRIER

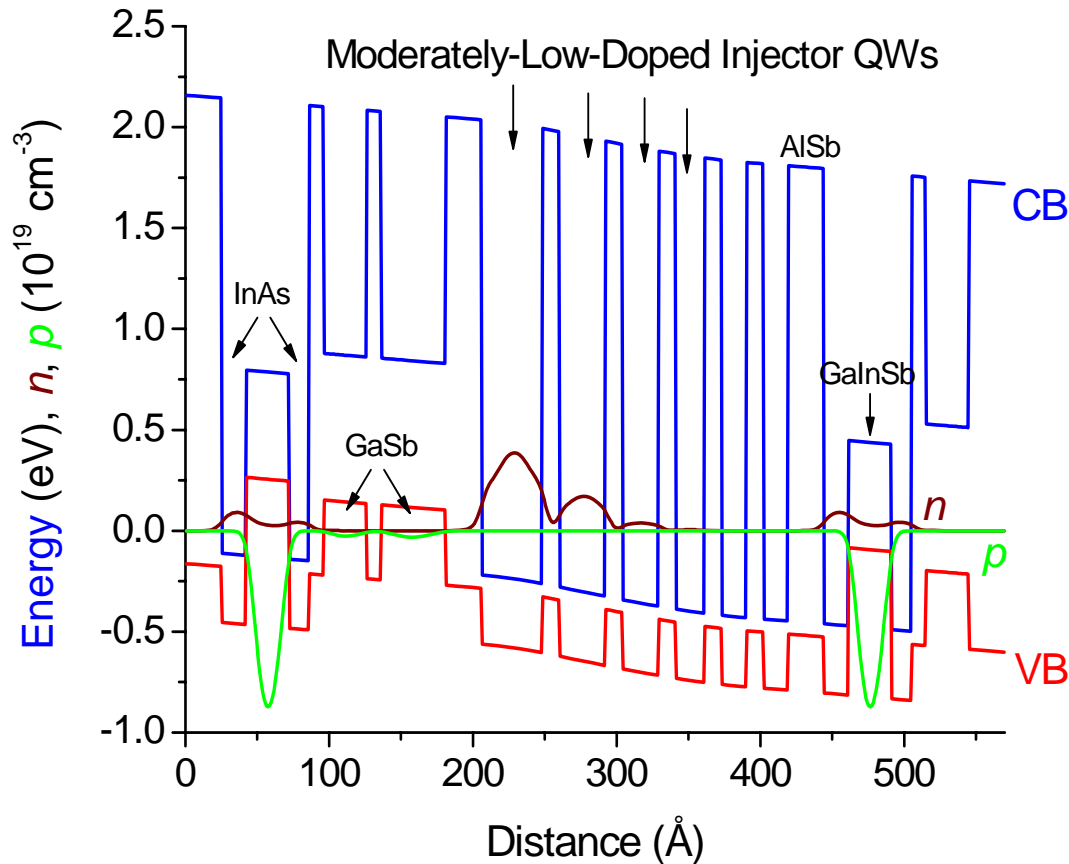


With thresholds reduced to $\approx 400 \text{ A/cm}^2$ by 2008, RT cw became routine
Were we approaching the fundamental limit?



NO! – A SIGNIFICANT DESIGN FLAW REMAINED

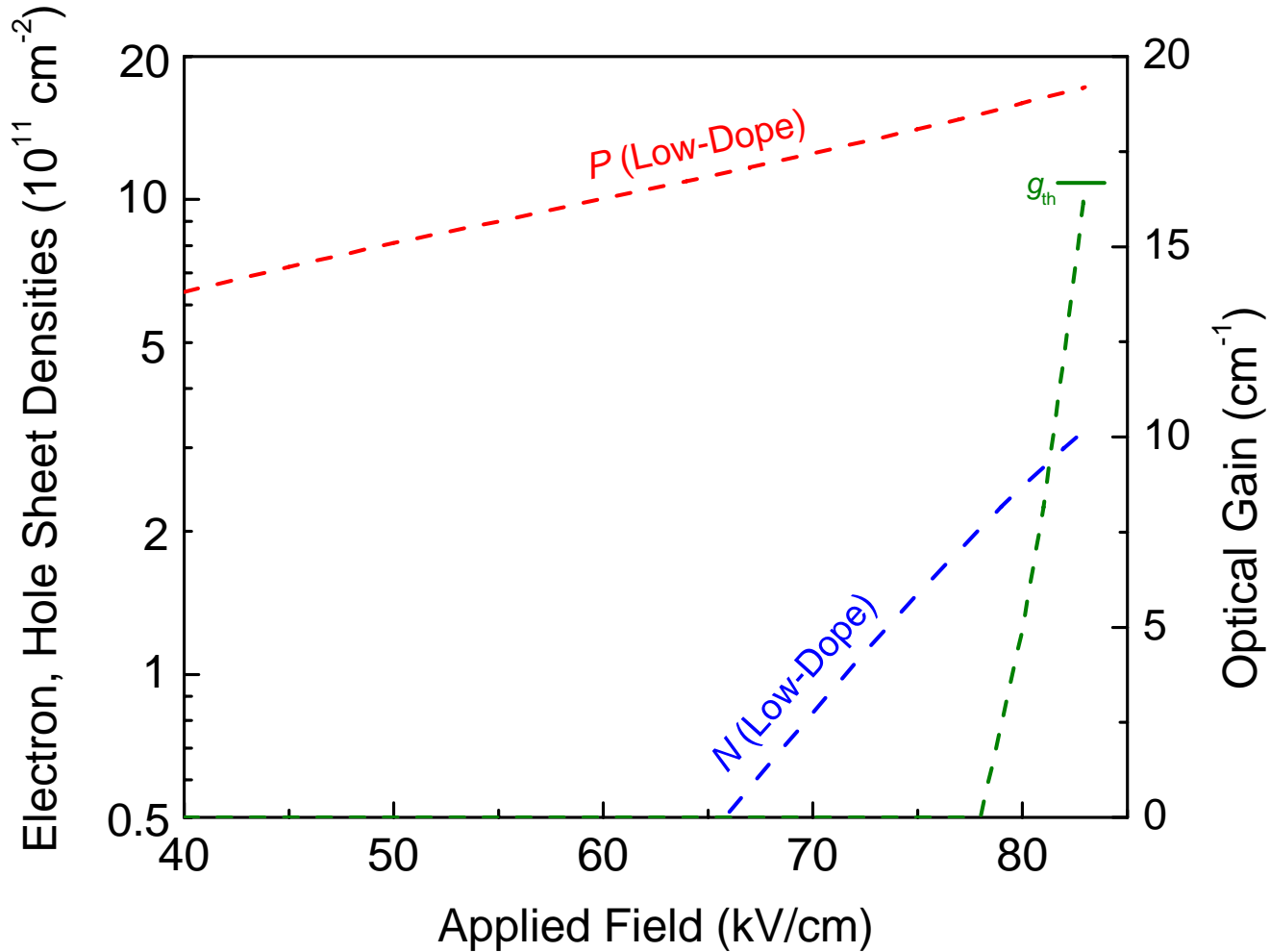
Simulations revealed that conventional designs with moderate n-doping ($\approx 4 \times 10^{17} \text{ cm}^{-3}$) of injector QWs suffered from serious hole/electron population imbalance in active QWs



Even though more electrons than holes throughout the stage (due to doping), most electrons populated the injector while most holes populated the active QWs



DENSITIES & GAIN vs. BIAS (CONVENTIONAL)

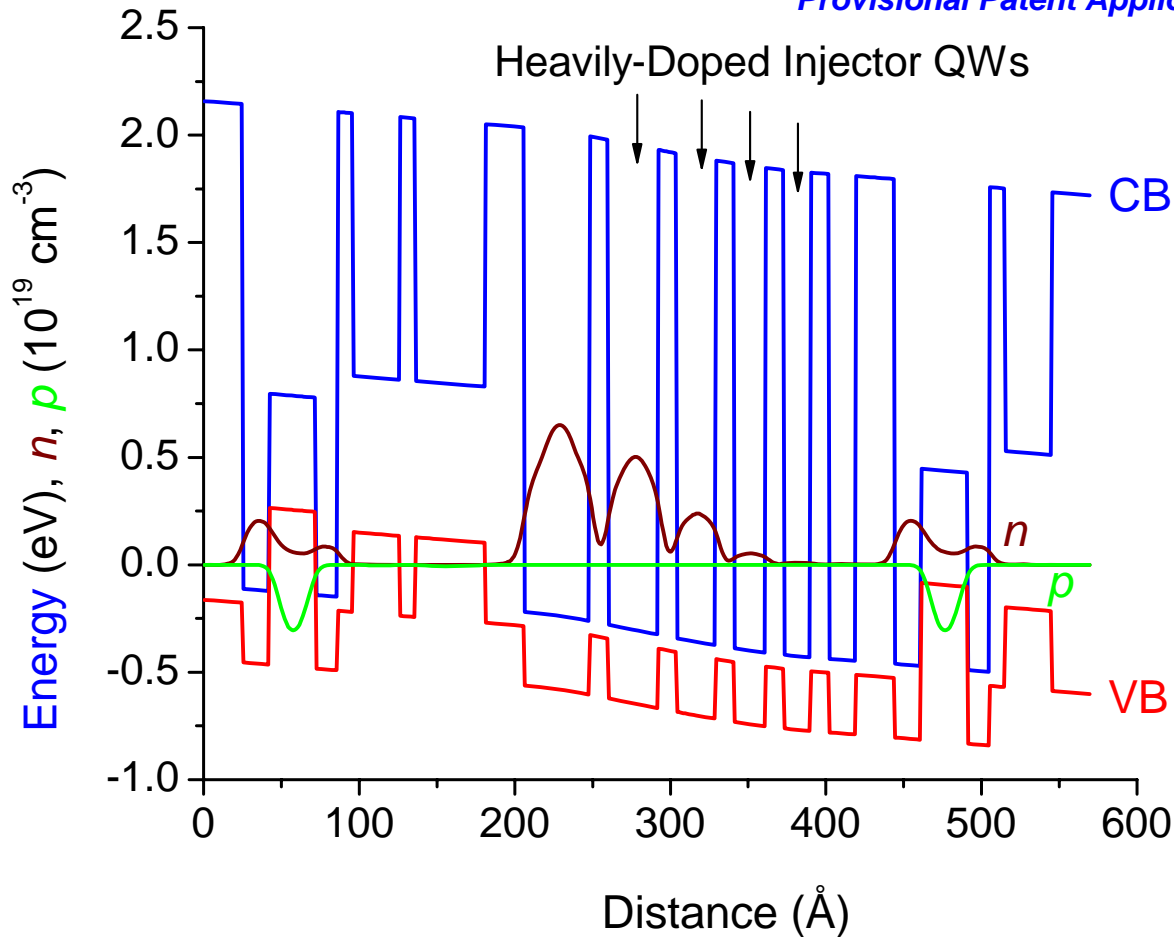


> 5x more holes than electrons in active QWs at threshold – Consequence is excessive internal losses & Auger non-radiative decay



SOLUTION: INCREASE INJECTOR DOPING LEVEL BY > ORDER OF MAGNITUDE

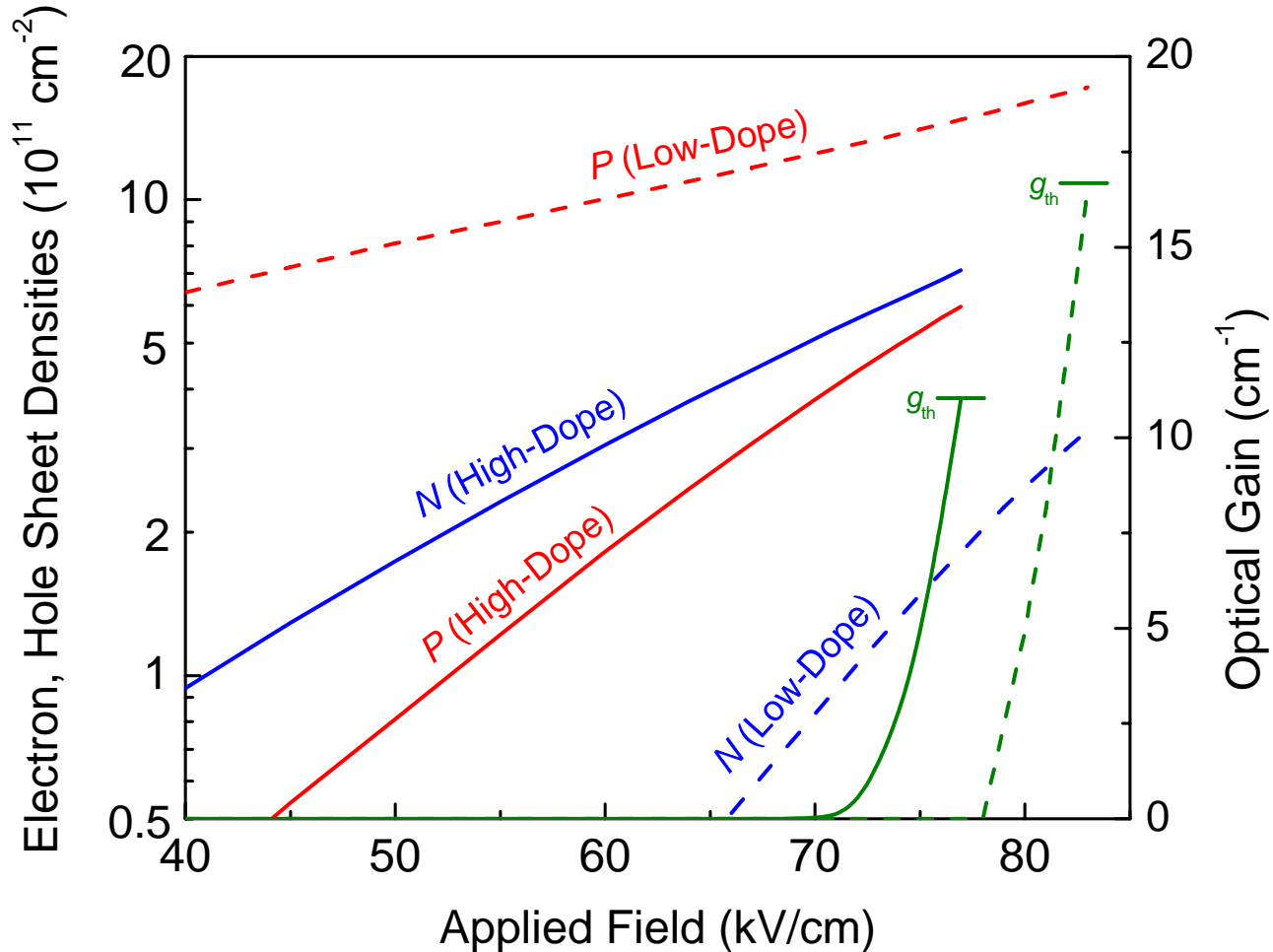
[Vurgaftman et al., Nature Com., December 2011; U.S. Provisional Patent Application No. 61477191 (2011)]



Heavy n-doping of injector "rebalances" active electron & hole populations, to make them roughly equal



DENSITIES & GAIN vs. BIAS (REBALANCED)

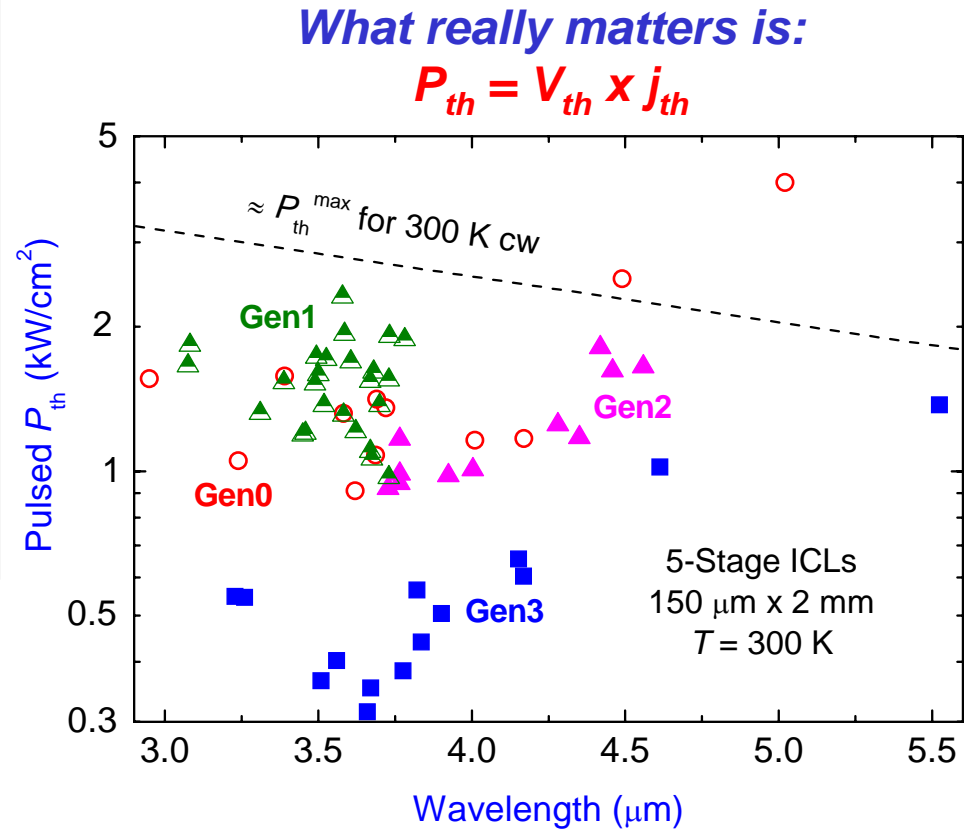
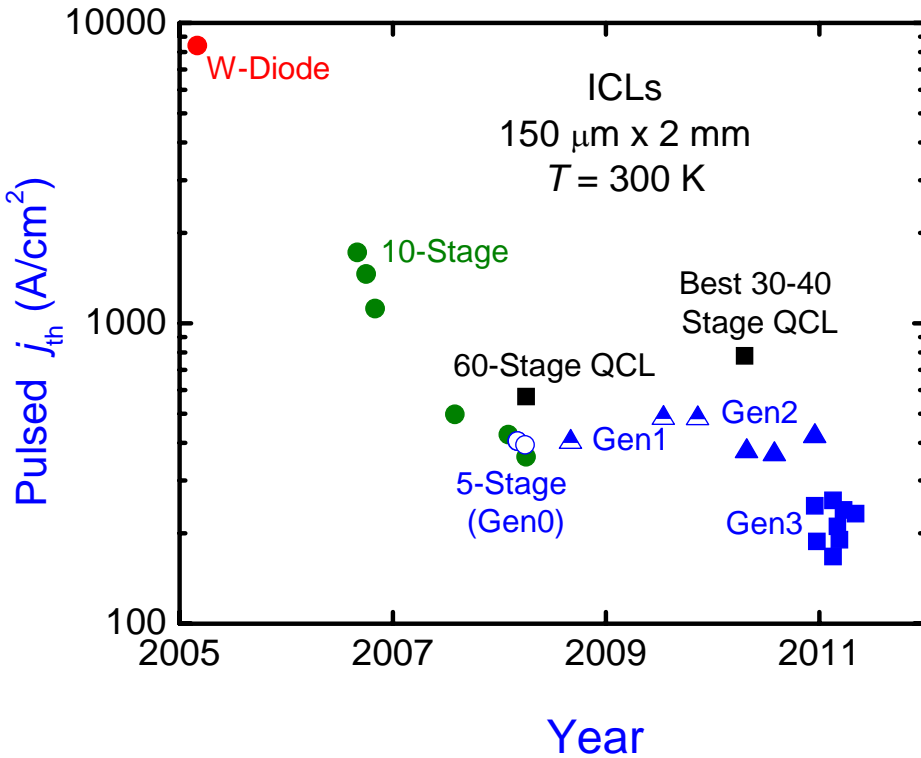


Simulations predicted that rebalancing should enable lasing at much lower carrier concentration, plus longer Auger lifetime & lower loss (because much lower P_{th})



REBALANCING (Gen3) SUBSTANTIALLY REDUCES EXPERIMENTAL THRESHOLDS

All Gen3 devices significantly out-perform all previous ICLs

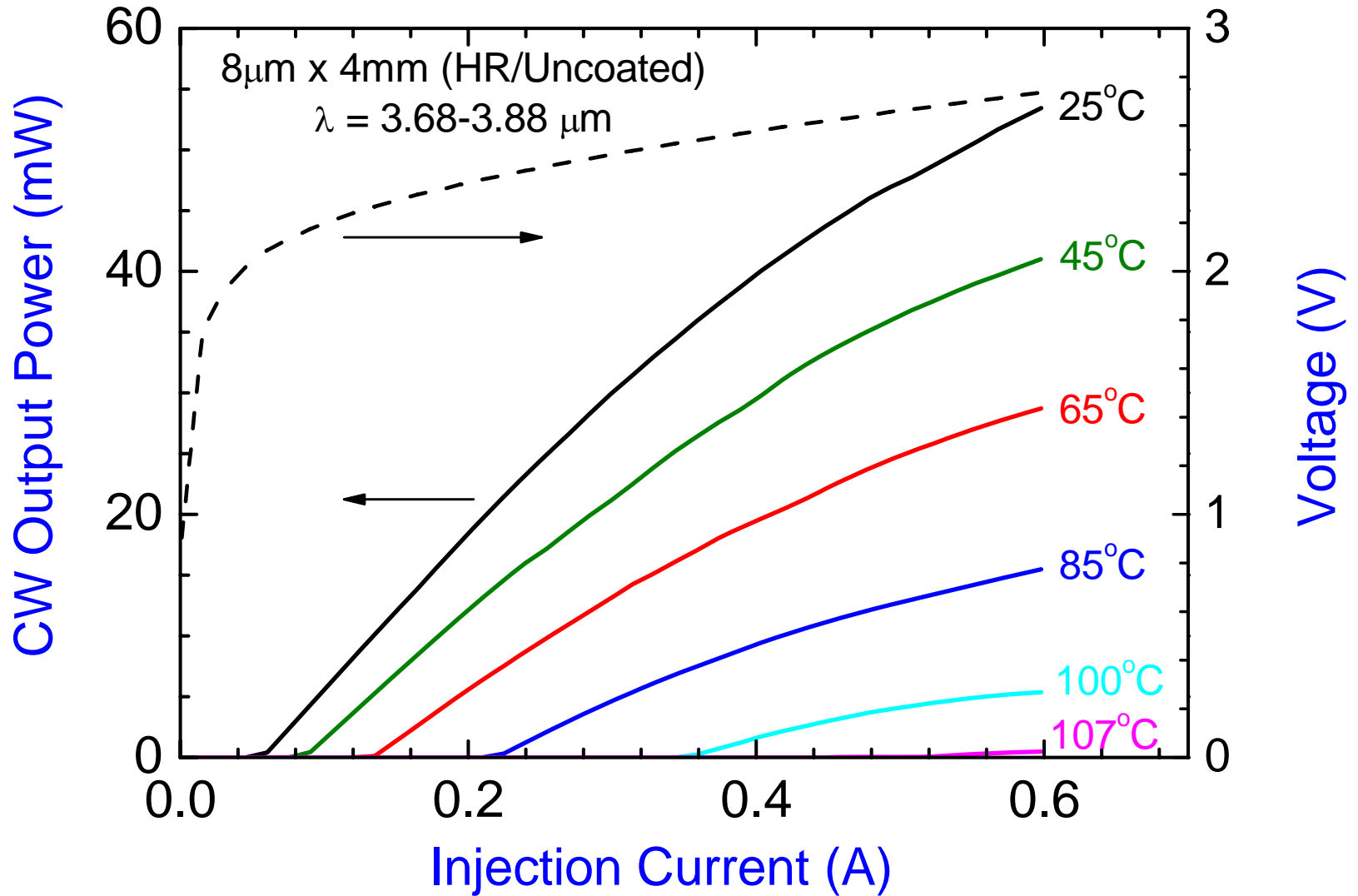


Lower power dissipation means longer battery lifetime (to $\lambda > 5 \mu m$!)

Record QCL value: $P_{th} \approx 10 kW/cm^2$



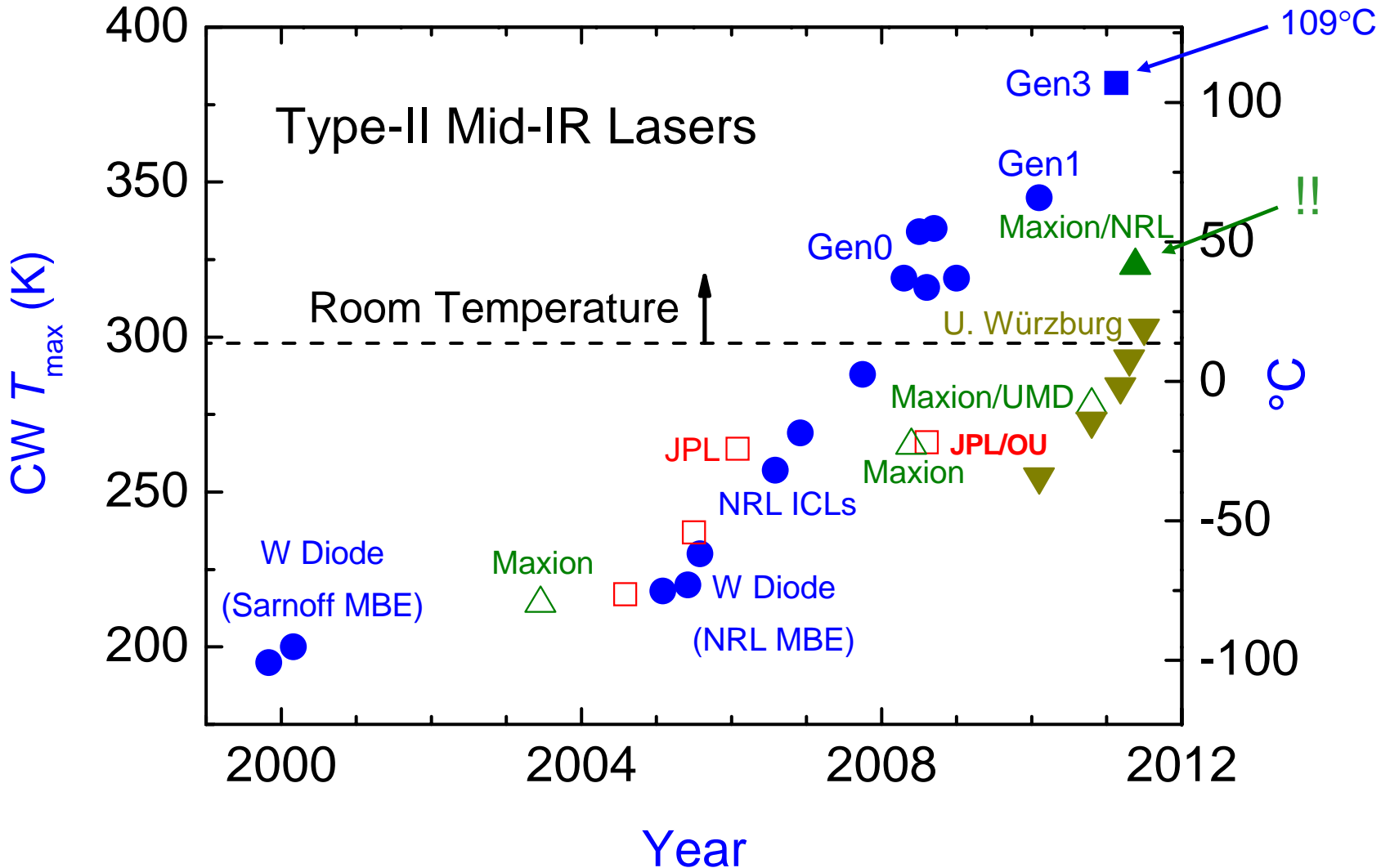
NARROW RIDGES: CW TO EVEN HIGHER T_{max}



CW operation to 107 $^{\circ}$ C



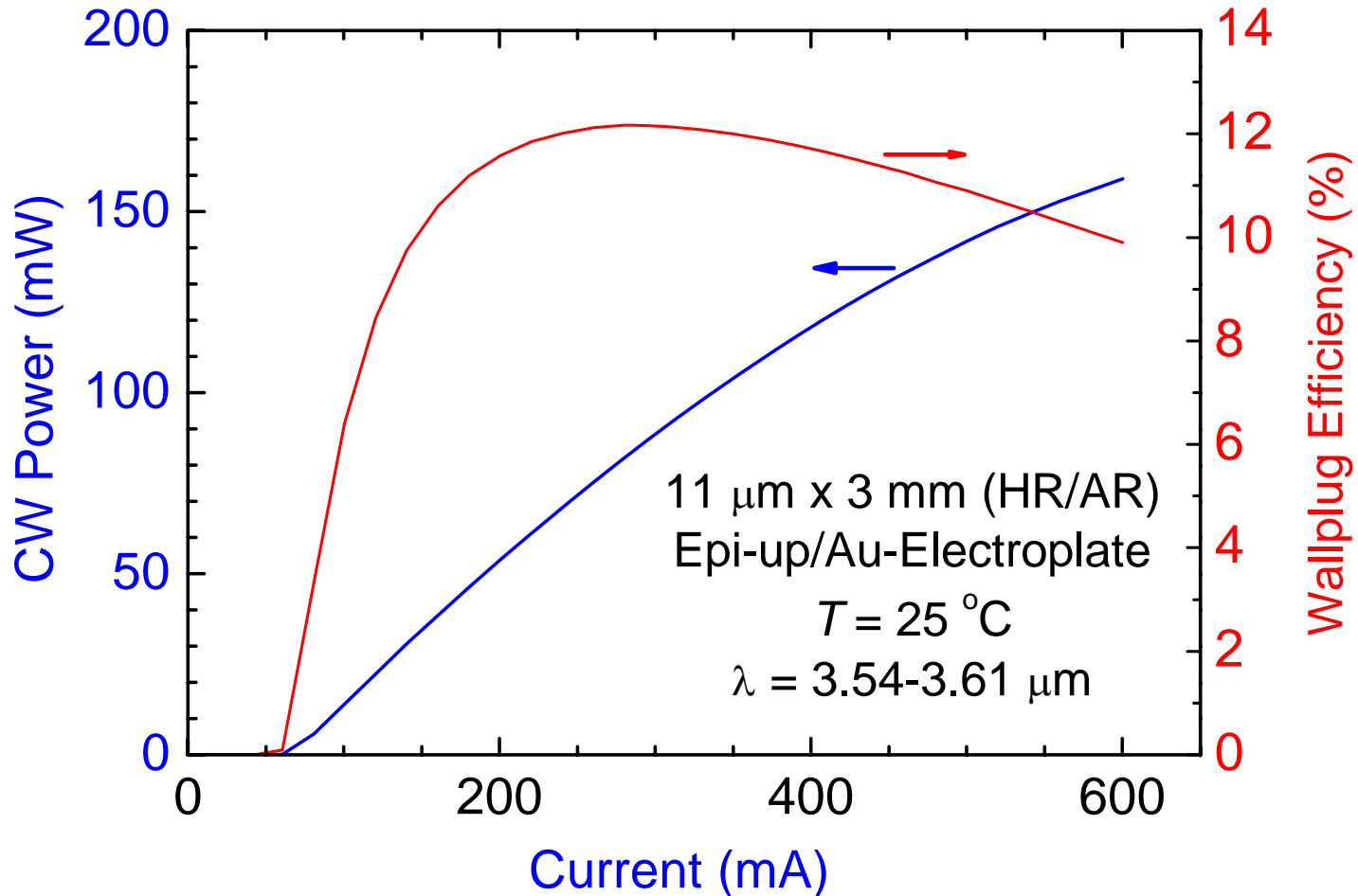
HIGHER CW OPERATING TEMPERATURE



Also: Maxion/PSI growth to NRL ICL design (Gen2) yielded nearly identical performance to NRL ICLs – Commercialization on the way!



HIGH CW POWER & WALLPLUG EFFICIENCY



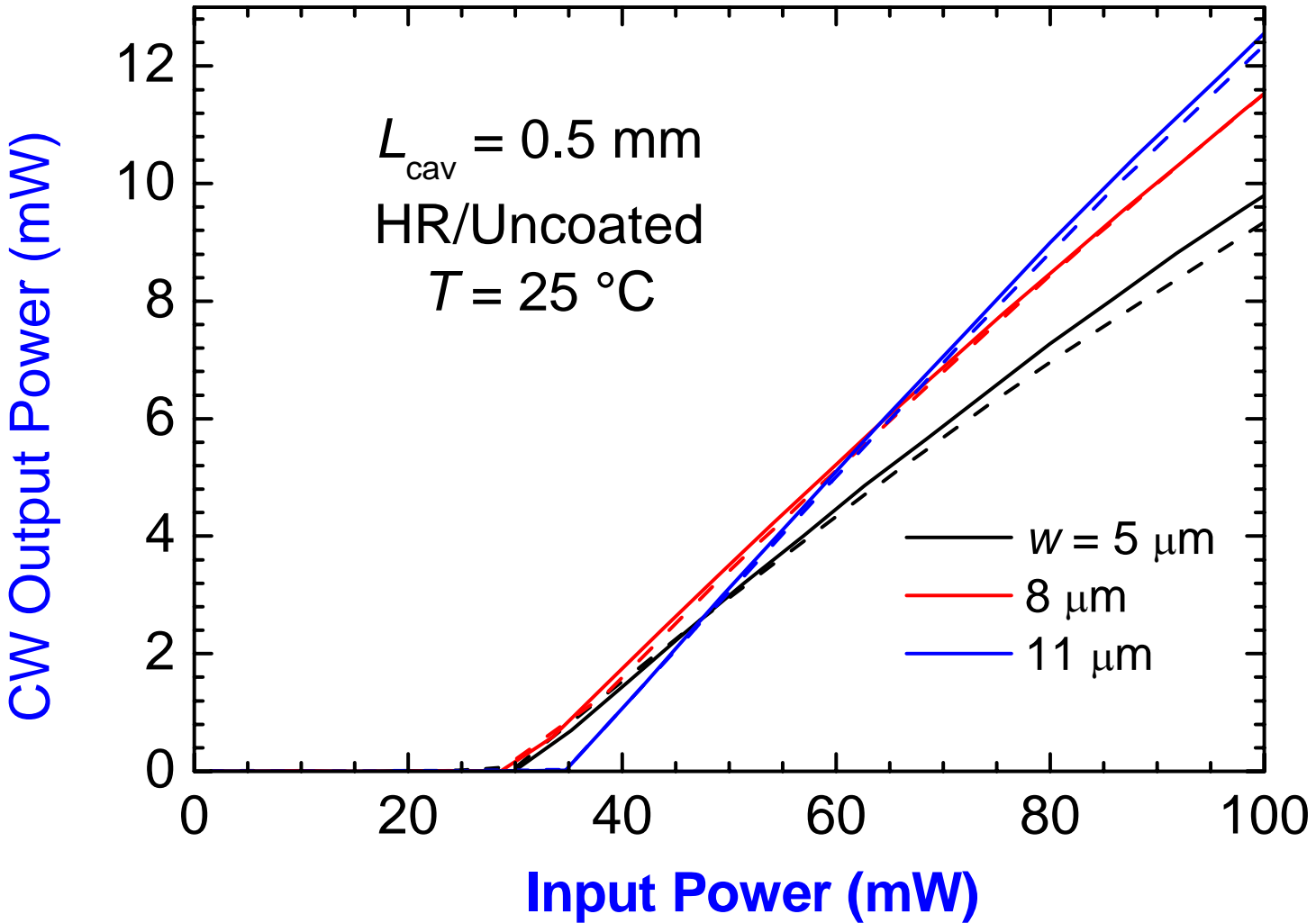
[Vurgaftman et al., Nature Com. 2, 585 (2011)]

$P_{\text{max}}^{\text{cw}} = 159\text{ mW}$ cw at room temperature (Beam quality $M^2 \approx 3$ @ $j > 10 \times j_{\text{th}}$)
WPE up to 12.2%, & still 9.9% at P_{max} (Shorter cavity: WPE = 13.5% @ 25 °C)



EXTREMELY LOW INPUT POWER THRESHOLD

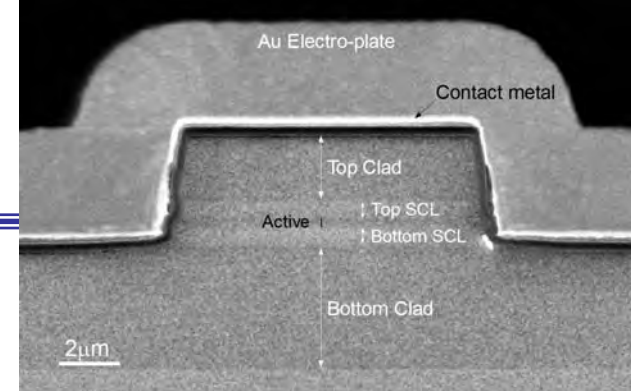
[Vurgaftman et al., Nature Com. 2, 585 (2011)]



$T = 25 \text{ }^\circ\text{C}$: **Input for lasing < 30 mW**
Best QCL value ever reported: 830 mW

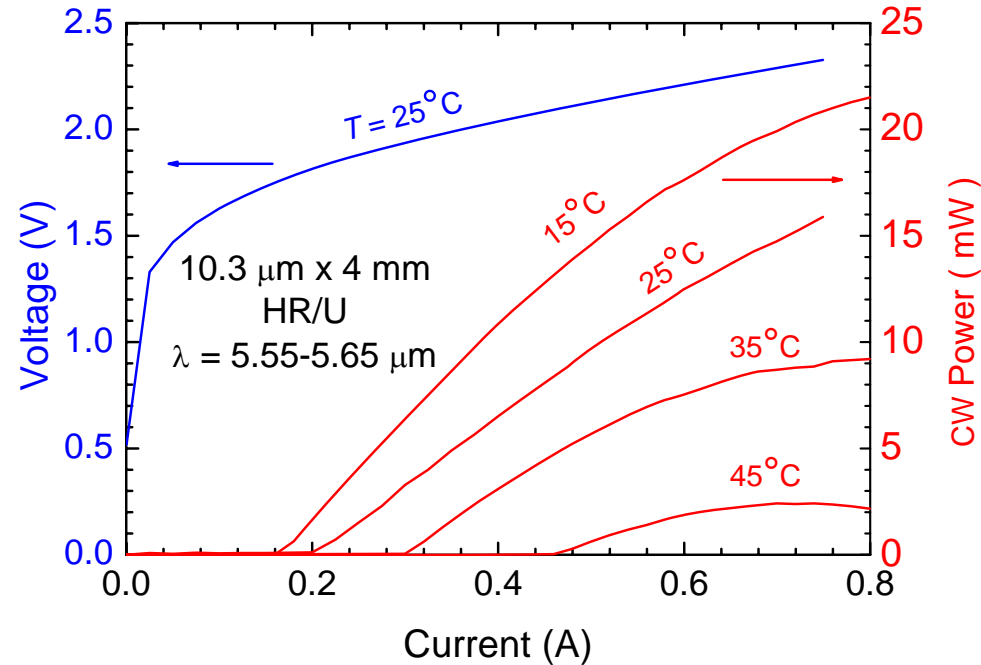
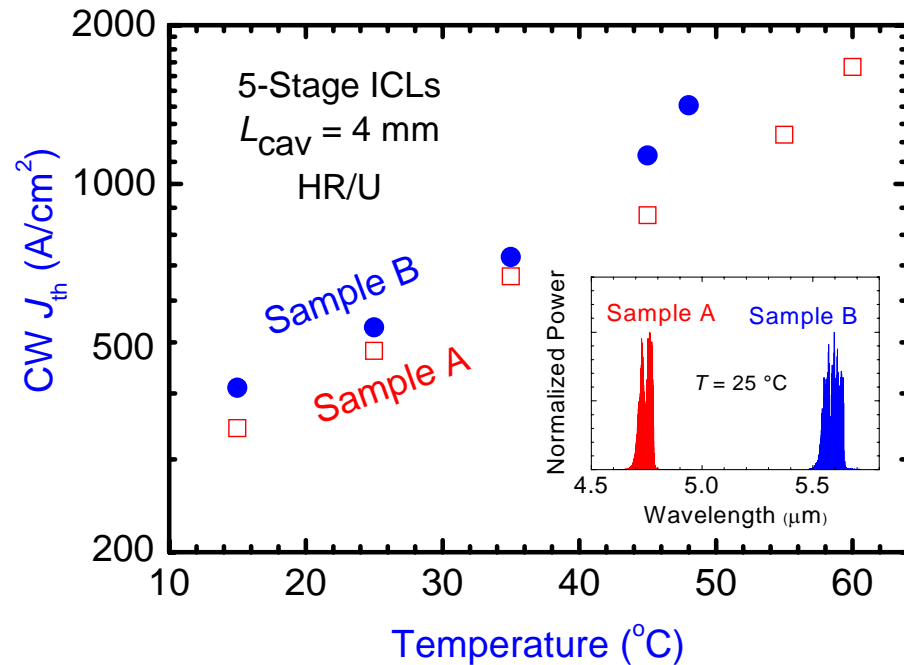


ROOM TEMP CW @ $\lambda > 4.5 \mu\text{m}$



Narrow ridges processed from longest- λ wafers

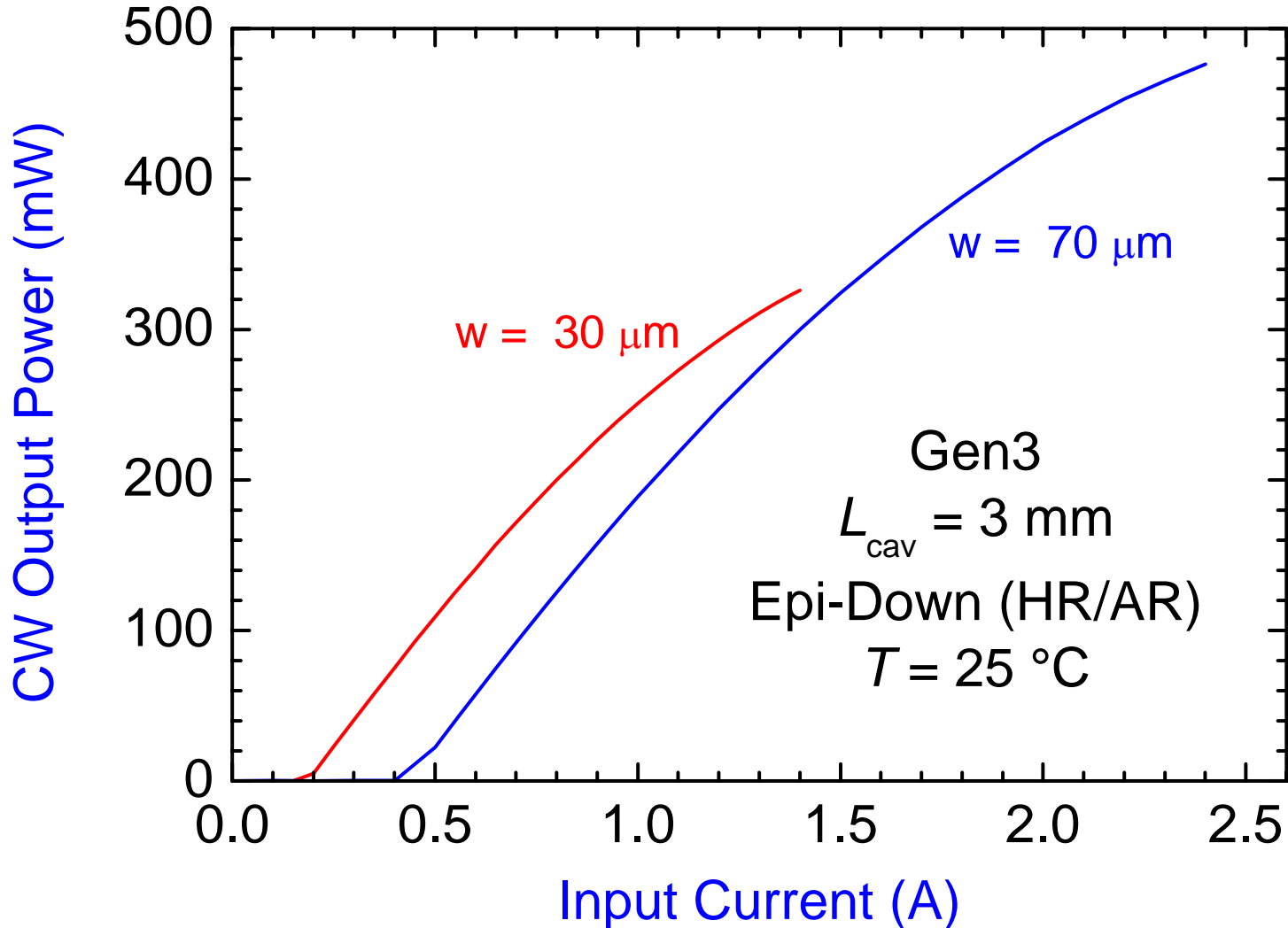
Bewley et al., submitted to Opt. Expr.



Both produced $> 15 \text{ mW}$ of cw power @ $T = 25^{\circ}\text{C}$
Operation to $T_{\text{max}}^{\text{cw}} = 60^{\circ}\text{C}$ ($4.9 \mu\text{m}$) & 48°C ($5.7 \mu\text{m}$)



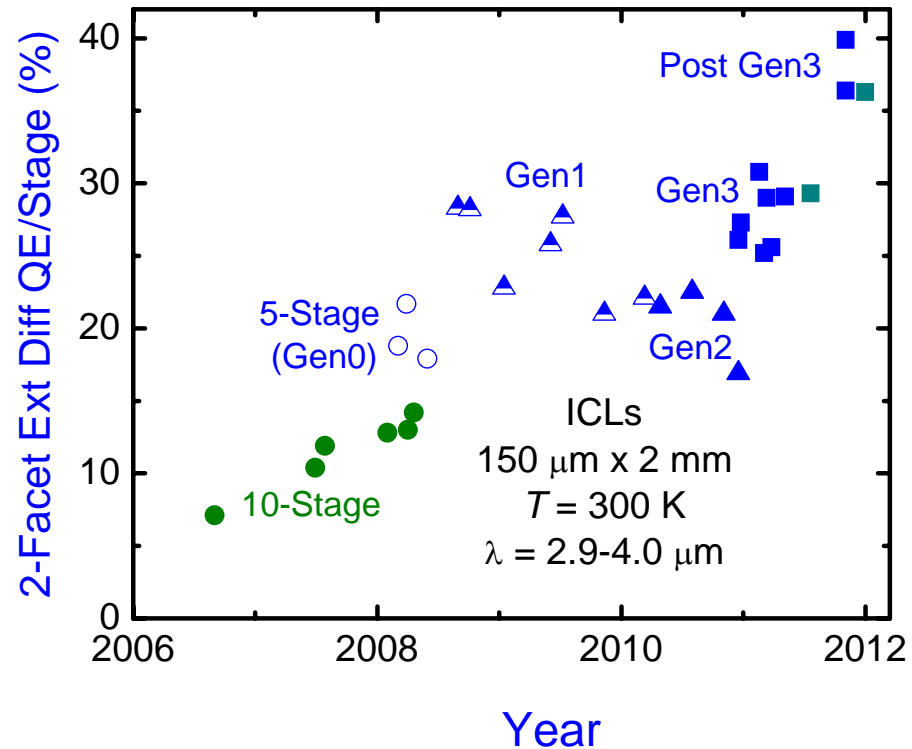
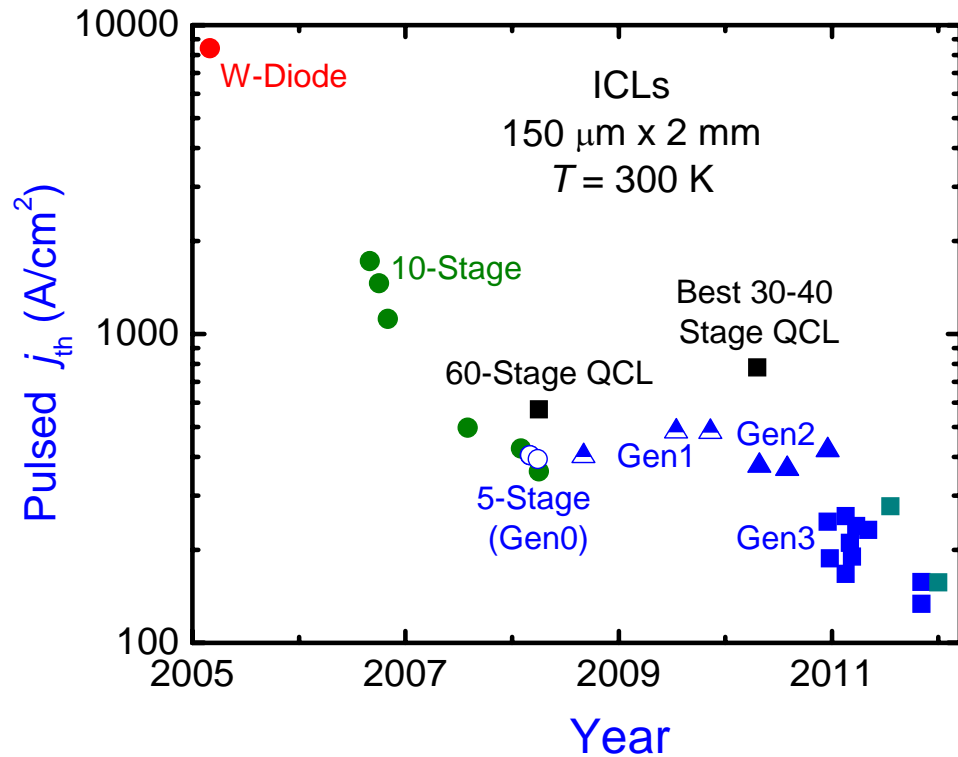
& THE LATEST: EPI-DOWN MOUNTING (BROAD AREA)



$P_{\text{max}}^{\text{cw}} > 470 \text{ mW}$ at room temperature from 70- μm -wide ridge



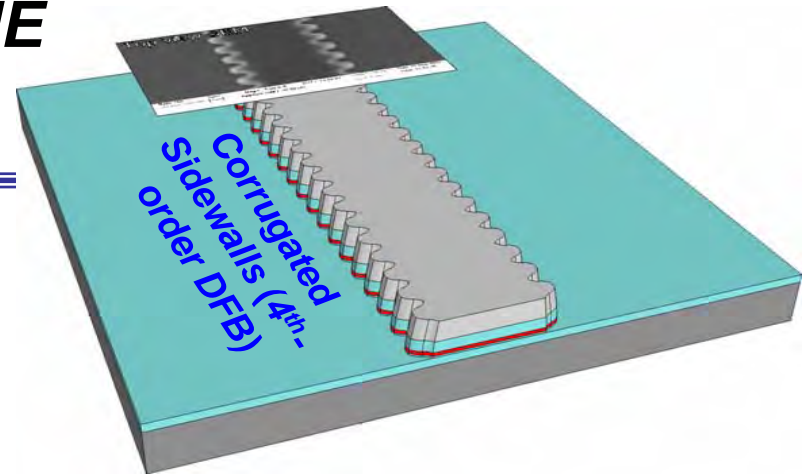
NEW & IMPROVED WAFERS FROM 2 NRL MBEs



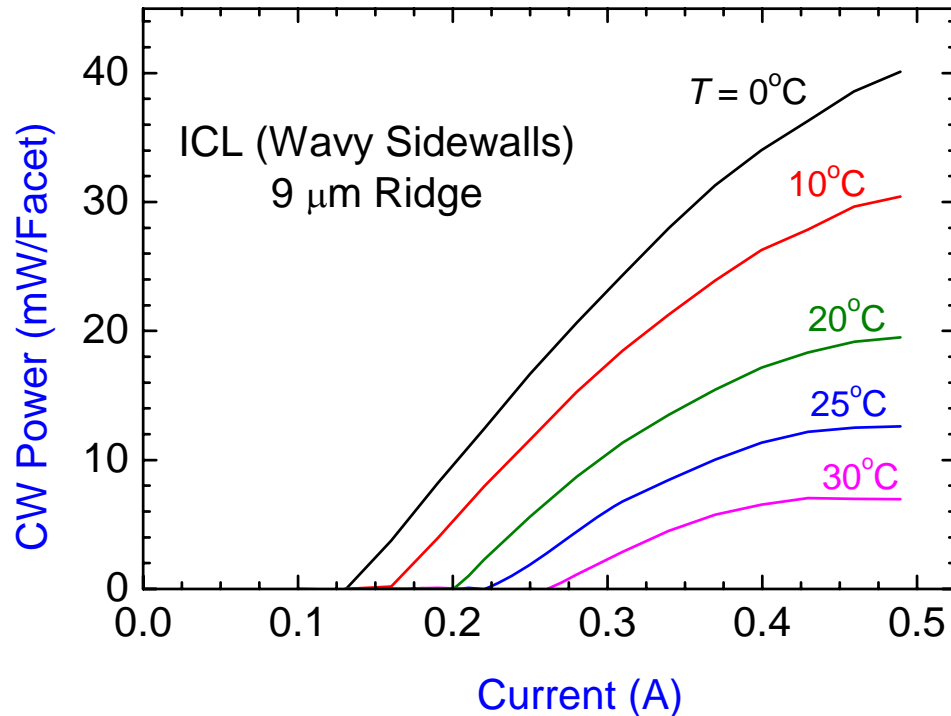
Thresholds dropped & efficiencies increased even further (Why?)



NARROW SPECTRAL LINE (Gen1 DEVICES)



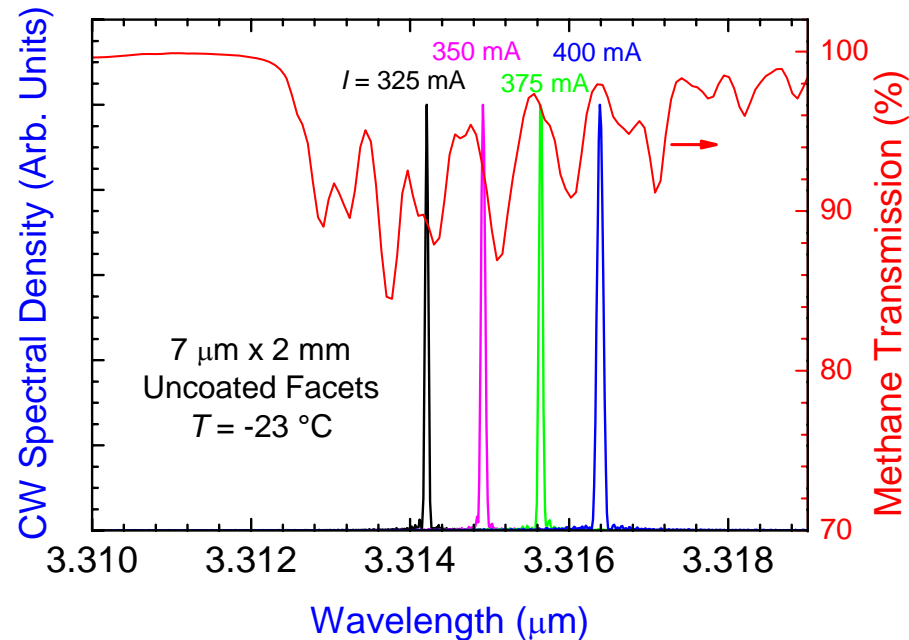
C.S. Kim et al., APL 95, 231103 (2009)



**12 mW cw in single spectral line
@ 25 °C; 29 mW @ 0 °C**

Also:

**45 mW & 7.6% WPE
in single mode @ -20 °C**

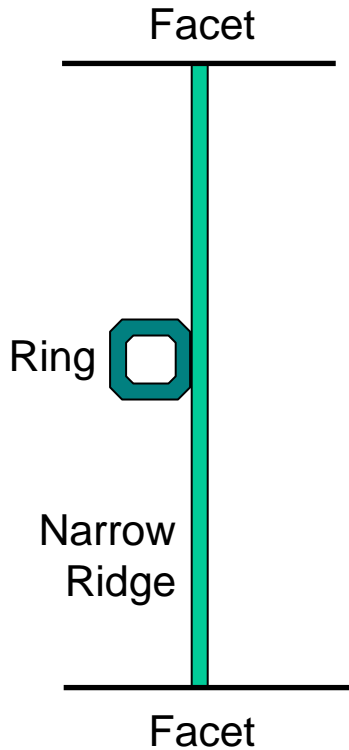
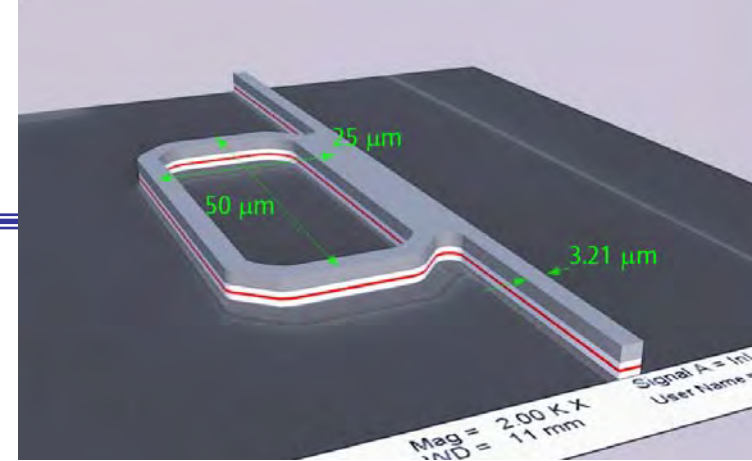


**Single-mode ridge spectrum,
superimposed with methane
absorption lines**



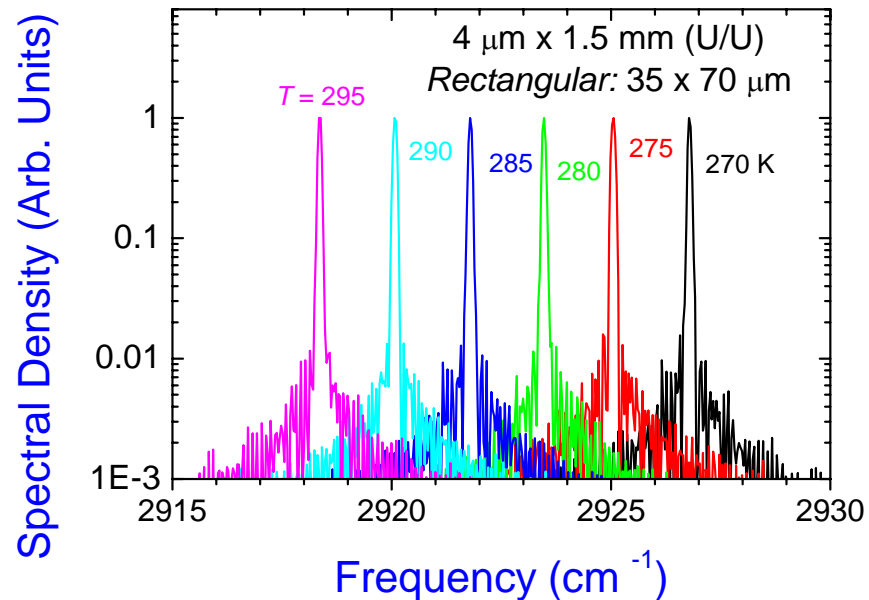
RING RESONATOR ICLs

**Coupled cavity lasers on
Fabry-Perot & ring modes
coinciding closest to gain peak**



**Ring resonance selects
single longitudinal mode**

Single-Mode Output:



**Narrow linewidth over extended temperature range –
Up to 5 mW cw output into single spectral mode at 2 °C**

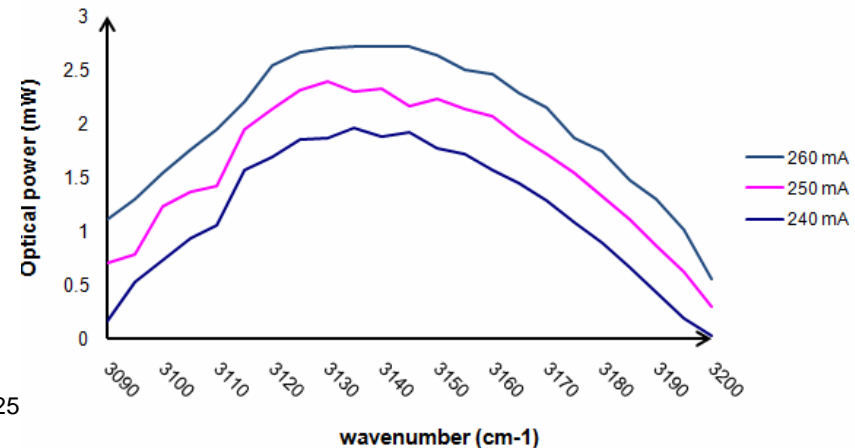
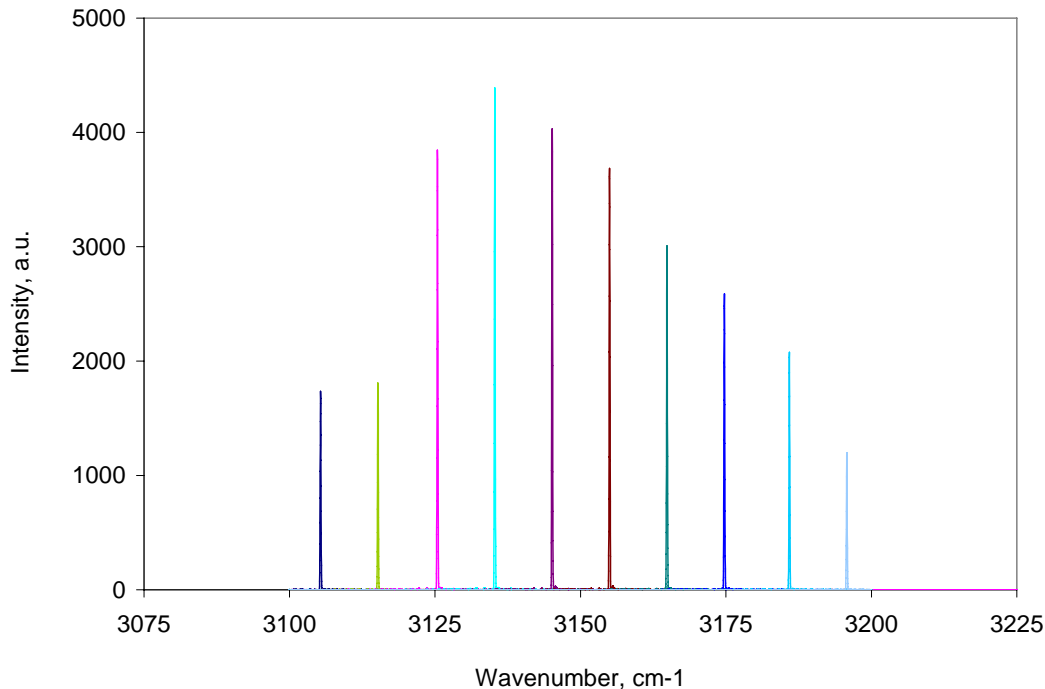
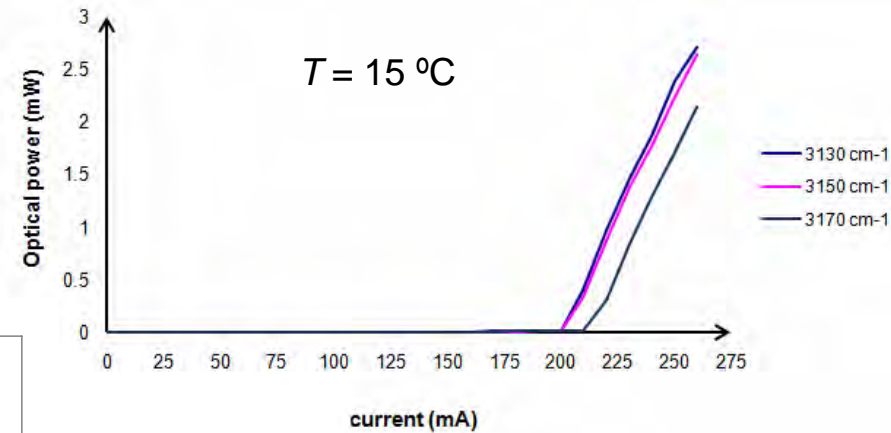


EXTERNAL CAVITY ICL [with Daylight Solutions]



Caffey et al., Opt. Expr. 18, 15691 (2010)

- Narrow linewidth in EC-ICL configuration
- 170 nm tuning range
- > 1 mW cw @ all λ (PA1 Generation)
- Low power consumption (< 1 W)





ICL STATUS

- High wafer yield despite design complexity
- Carrier rebalancing (Gen3) substantially improves all performance characteristics
- *Low Input Power*: $< 30 \text{ mW}$ @ $T = 25 \text{ }^\circ\text{C}$ (RT) is $> 25 \times$ lower than best QCL result
 - Dramatic extension of battery lifetime
- *CW Narrow Ridges (Gen3)*:
 - $T_{\text{max}} = 109 \text{ }^\circ\text{C}$
 - RT: $P_{\text{max}} = 159 \text{ mW}$, WPE = 13.5%, $M^2 = 1.0\text{-}3.1$
- *Latest wafers (Pulsed @ 300 K)*:
 - $j_{\text{th}} = 134 \text{ A/cm}^2$, EDQE = 40%
- *Corrugated-Sidewall DFB (Gen1)*:
 - $P_{\text{max}} = 12 \text{ mW}$ in narrow line @ RT
- Wafers already on hand can provide RT cw @ λ spanning 2.9 to 5.7 μm
- **Bottom line: ICLs ready & able for field spectroscopy!**

